



### Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	$I_D$
120V	5.4m $\Omega$ @10V	90A
	6.6m $\Omega$ @4.5V	

### Feature

- Split Gate Trench Technology
- Low  $R_{DS(ON)}$
- Low Gate Charge
- Low Gate Resistance
- 100% UIS Tested
- Optimized for High Speed Smooth Switching

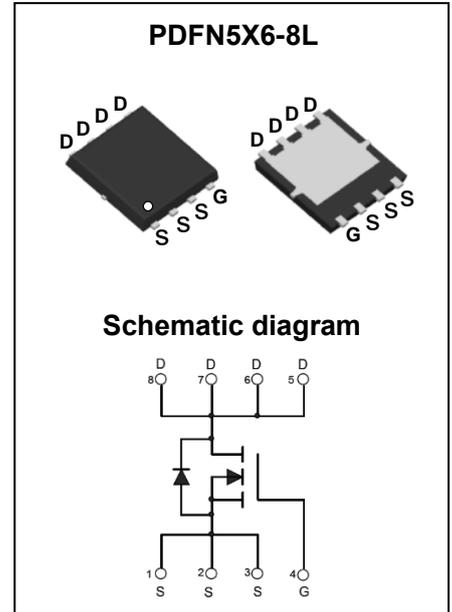
### Application

- Power Switching Application
- DC/DC Converters

### MARKING:



T054N12L = Device Code  
XX = Date Code  
Solid Dot = Green Indicator



### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain - Source Voltage	$V_{DS}$	120	V
Gate - Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>1</sup>	$T_C = 25^\circ\text{C}$	$I_D$	90 A
	$T_C = 120^\circ\text{C}$	$I_D$	57 A
Pulsed Drain Current <sup>2</sup>	$I_{DM}$	360	A
Single Pulsed Avalanche Current <sup>3</sup>	$I_{AS}$	35	A
Single Pulsed Avalanche Energy <sup>3</sup>	$E_{AS}$	245	mJ
Power Dissipation <sup>5</sup>	$T_C = 25^\circ\text{C}$	$P_D$	118 W
Thermal Resistance from Junction to Ambient <sup>6</sup>	$R_{\theta JA}$	56	$^\circ\text{C}/\text{W}$
Thermal Resistance from Junction to Case	$R_{\theta JC}$	1.06	$^\circ\text{C}/\text{W}$
Junction Temperature	$T_J$	150	$^\circ\text{C}$
Storage Temperature	$T_{STG}$	-55~ +150	$^\circ\text{C}$

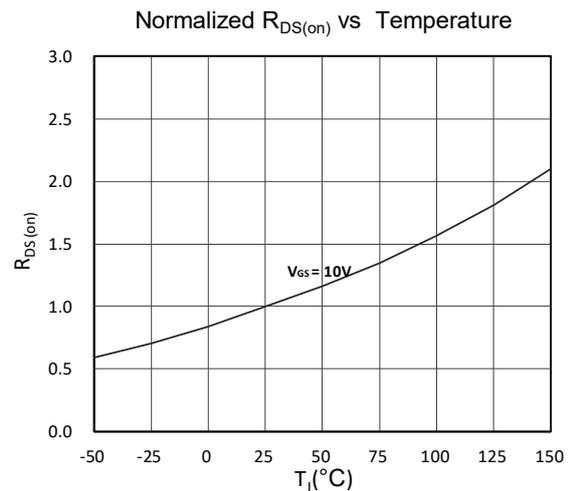
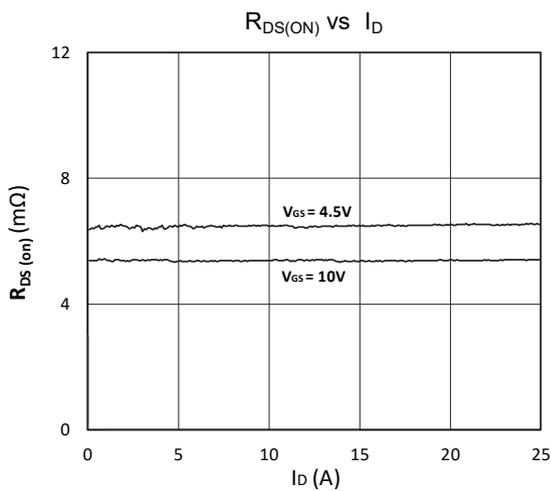
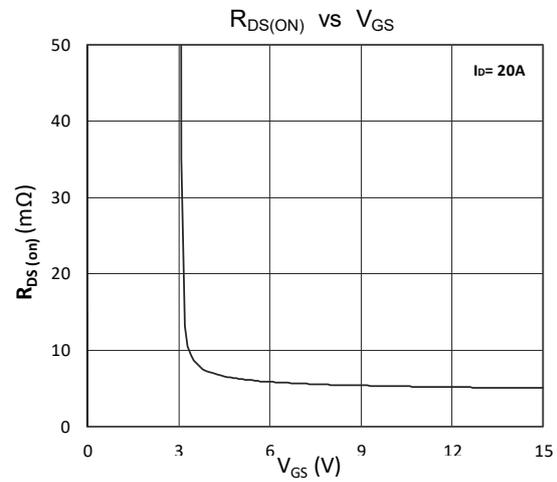
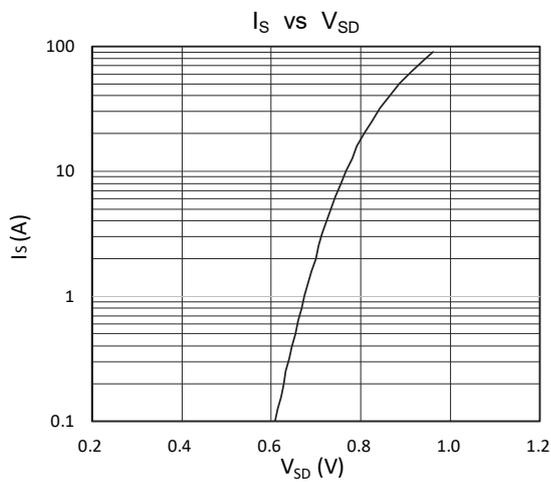
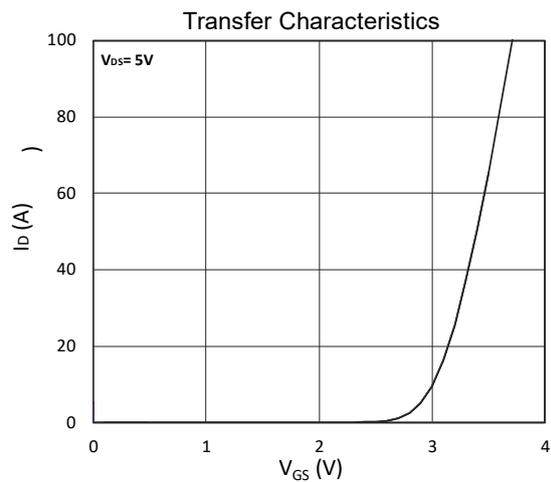
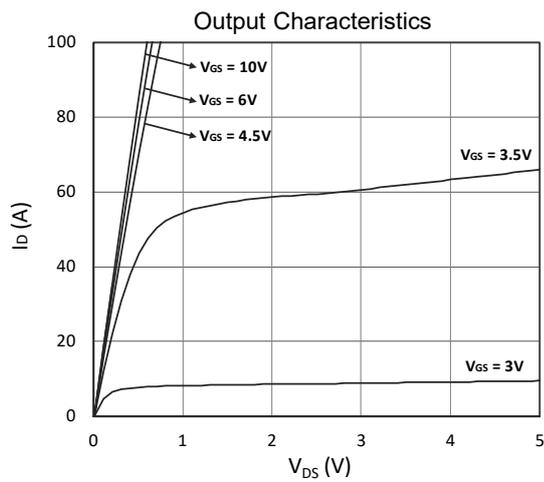
## MOSFET ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

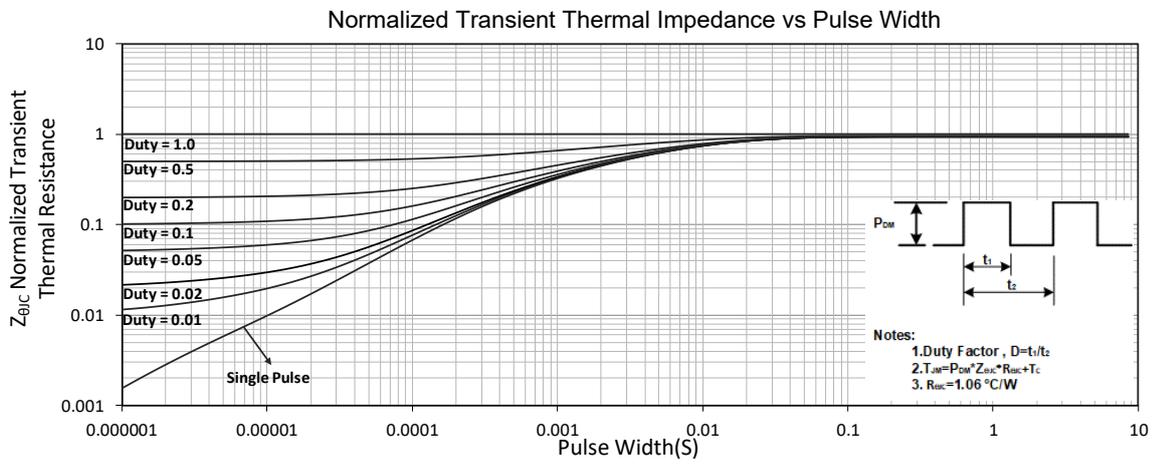
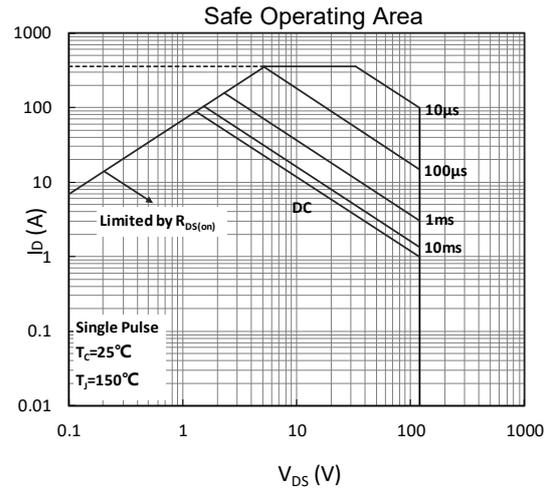
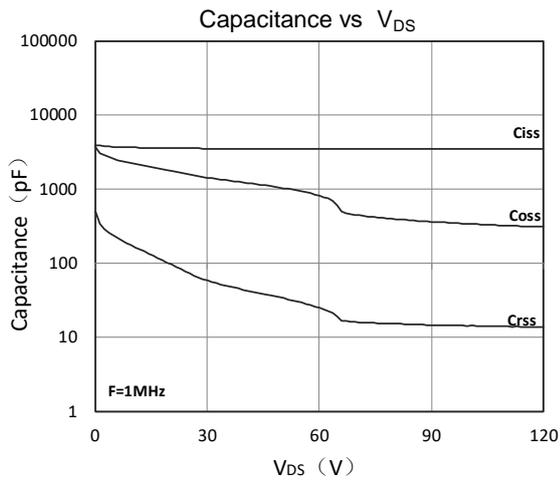
Parameter	Symbol	Test Condition	Min	Type	Max	Unit
<b>Off Characteristics</b>						
Drain - Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	120			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 120V, V_{GS} = 0V$			1	$\mu A$
Gate - Body Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			$\pm 100$	nA
<b>On Characteristics<sup>4</sup></b>						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1	2	3	V
Drain-source On-resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 20A$		5.4	7.0	m $\Omega$
		$V_{GS} = 4.5V, I_D = 20A$		6.6	9.0	
Forward Transconductance	$g_{FS}$	$V_{DS} = 10V, I_D = 20A$		92		S
<b>Dynamic Characteristics</b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 60V, V_{GS} = 0V, f = 1MHz$		3415		pF
Output Capacitance	$C_{oss}$			520		
Reverse Transfer Capacitance	$C_{rss}$			12		
Gate Resistance	$R_g$	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$		3		$\Omega$
<b>Switching Characteristics</b>						
Total Gate Charge	$Q_g$	$V_{DS} = 60V, V_{GS} = 10V, I_D = 20A$		53		nC
Gate-source Charge	$Q_{gs}$			10		
Gate-drain Charge	$Q_{gd}$			9.5		
Turn-on Delay Time	$t_{d(on)}$	$V_{DD} = 60V, V_{GS} = 10V, I_D = 20A,$ $R_G = 3\Omega$		12		ns
Turn-on Rise Time	$t_r$			10		
Turn-off Delay Time	$t_{d(off)}$			52		
Turn-off Fall Time	$t_f$			19		
<b>Source - Drain Diode Characteristics</b>						
Diode Forward Voltage <sup>4</sup>	$V_{SD}$	$V_{GS} = 0V, I_S = 20A$			1.2	V
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 20A, dI_F/dt = 500A/\mu s$		66		ns
Body Diode Reverse Recovery Charge	$Q_{rr}$				113	

Notes :

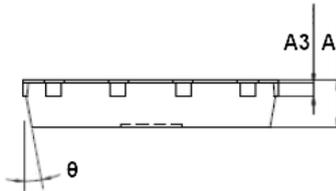
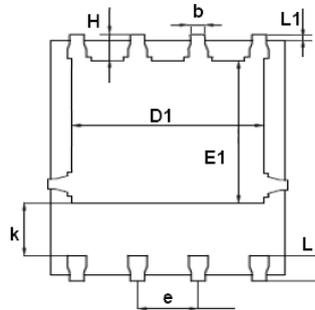
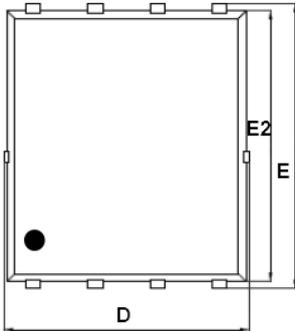
1. The maximum current rating is limited by package. And device mounted on a large heatsink
2. Pulse Test : Pulse Width  $\leq 10\mu s$ , duty cycle  $\leq 1\%$ .
3. EAS condition:  $V_{DD} = 25V, V_{GS} = 10V, L = 0.4mH, R_G = 25\Omega$  Starting  $T_J = 25^\circ\text{C}$ .
4. Pulse Test : Pulse Width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .
5. The power dissipation  $P_D$  is limited by  $T_{J(MAX)} = 150^\circ\text{C}$ . And device mounted on a large heatsink
6. Device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$ .

**Typical Characteristics**





## PDFN5X6-8L Package Information



SYMBOL	MM	
	MIN	MAX
A	0.90	1.20
A3	0.15	0.35
D	4.80	5.40
E	5.90	6.35
D1	3.61	4.31
E1	3.30	3.92
E2	5.50	6.06
k	1.10	-
b	0.30	0.51
e	1.27BSC	
L	0.38	0.71
L1	0.05	0.36
H	0.38	0.71
$\theta$	0°	12°